

| | | | |
|-----------------------------------|-------------------------|---|---------------------------|
| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination BURTON ET AL. | |
| | Examiner | Art Unit | Page <u>1</u> of <u>1</u> |
| | | Thu Ha T. Nguyen | 2155 |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|-------------------|----------------|
| A | US-6,192,405 B1 | 02-2001 | Bunnell, Karl Lee | 709/225 |
| B | US-6,351,776 B1 | 02-2002 | O'Brien et al. | 709/245 |
| C | US-6,629,127 B1 | 09-2003 | Deen et al. | 709/203 |
| D | US- | | | |
| E | US- | | | |
| F | US- | | | |
| G | US- | | | |
| H | US- | | | |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N | | | | | |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

